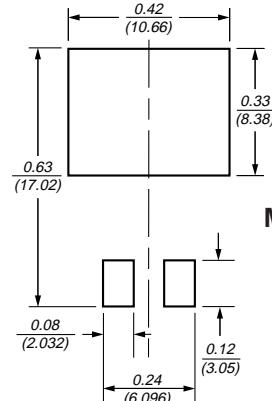
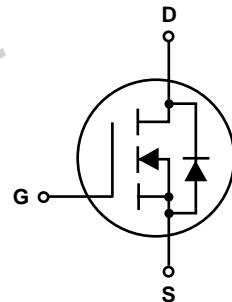
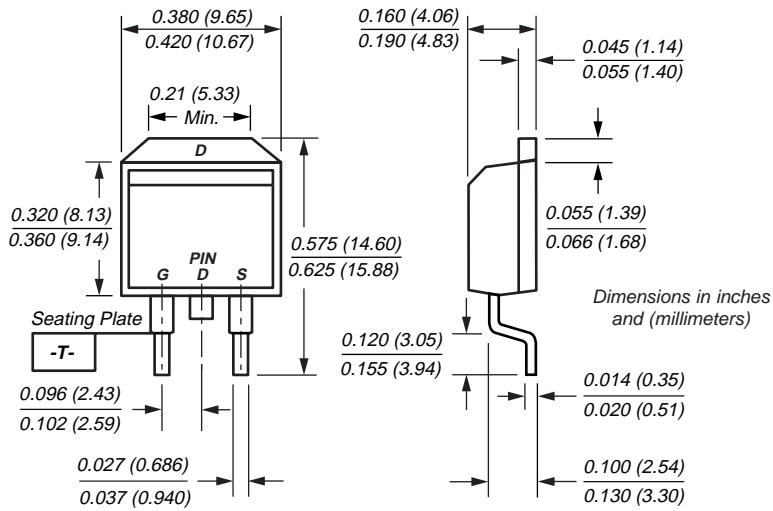




TRENCH
GENFET®

TO-263AB



Mechanical Data

Case: JEDEC TO-263 molded plastic body

Terminals: Leads solderable per MIL-STD-750, Method 2026

High temperature soldering guaranteed:
250°C/10 seconds at terminals

Mounting Position: Any **Weight:** 1.3g

Features

- Advanced Trench Process Technology
- High Density Cell Design for Ultra Low On-Resistance
- Specially Designed for Low Voltage DC/DC Converters
- Fast Switching for High Efficiency

Maximum Ratings and Thermal Characteristics (T_C = 25°C unless otherwise noted)

Parameter	Symbol	Limit	Unit
Drain-Source Voltage	V _{DS}	30	V
Gate-Source Voltage	V _{GSS}	±20	
Continuous Drain Current ⁽¹⁾	I _D	80	A
Pulsed Drain Current	I _{DM}	240	
Maximum Power Dissipation	P _D	69.4 27.8	W
Operating Junction and Storage Temperature Range	T _J , T _{Stg}	-55 to 150	°C
Lead Temperature (1/8" from case for 5 sec.)	T _L	275	°C
Junction-to-Case Thermal Resistance	R _{θJC}	1.8	°C/W
Junction-to-Ambient Thermal Resistance ⁽²⁾	R _{θJA}	40	°C/W

Notes: (1) Maximum DC current limited by the package
(2) 1-in² 2oz. Cu PCB mounted

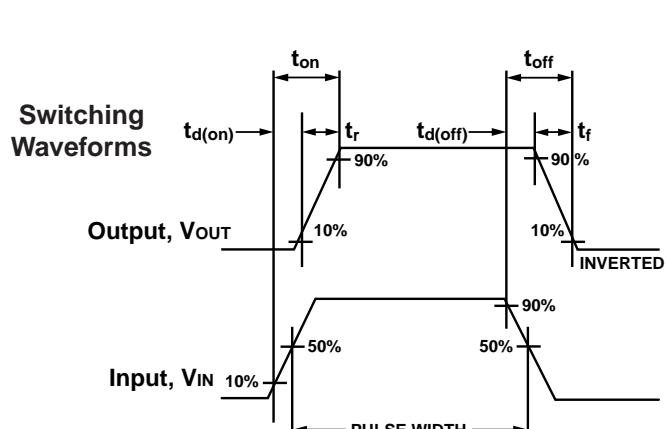
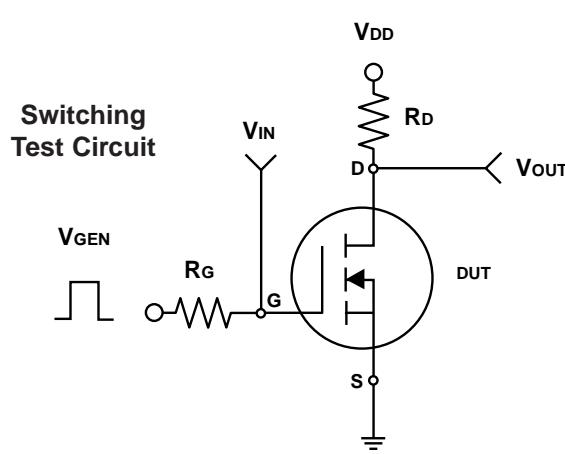
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N-Channel Enhancement-Mode MOSFET
Electrical Characteristics ($T_J = 25^\circ\text{C}$ unless otherwise noted)

Parameter	Symbol	Test Condition	Min	Typ	Max	Unit
Static						
Drain-Source Breakdown Voltage	BV_{DSS}	$\text{V}_{\text{GS}} = 0\text{V}, \text{I}_D = 250\mu\text{A}$	30	—	—	V
Drain-Source On-State Resistance ⁽¹⁾	$\text{R}_{\text{DS(on)}}$	$\text{V}_{\text{GS}} = 10\text{V}, \text{I}_D = 38\text{A}$	—	5.8	6.5	$\text{m}\Omega$
		$\text{V}_{\text{GS}} = 4.5\text{V}, \text{I}_D = 31\text{A}$	—	8.5	9.5	
Gate Threshold Voltage	$\text{V}_{\text{GS(th)}}$	$\text{V}_{\text{DS}} = \text{V}_{\text{GS}}, \text{I}_D = 250\mu\text{A}$	1.0	—	3.0	V
Zero Gate Voltage Drain Current	$\text{I}_{\text{DS}(\text{S})}$	$\text{V}_{\text{DS}} = 30\text{V}, \text{V}_{\text{GS}} = 0\text{V}$	—	—	1.0	μA
Gate-Body Leakage	I_{GSS}	$\text{V}_{\text{GS}} = \pm 20\text{V}, \text{V}_{\text{DS}} = 0\text{V}$	—	—	± 100	nA
On-State Drain Current ⁽¹⁾	$\text{I}_{\text{D(on)}}$	$\text{V}_{\text{DS}} \geq 5\text{V}, \text{V}_{\text{GS}} = 10\text{V}$	75	—	—	A
Forward Transconductance ⁽¹⁾	g_{fs}	$\text{V}_{\text{DS}} = 15\text{V}, \text{I}_D = 38\text{A}$	—	61	—	S
Dynamic						
Total Gate Charge	Q_g	$\text{V}_{\text{DS}}=15\text{V}, \text{I}_D=38\text{A}, \text{V}_{\text{GS}}=5\text{V}$	—	32.5	46	nC
Gate-Source Charge	Q_{gs}	$\text{V}_{\text{DS}} = 15\text{V}, \text{V}_{\text{GS}} = 10\text{V}$	—	63	90	
Gate-Drain Charge	Q_{gd}	$\text{I}_D = 38\text{A}$	—	11	—	
Turn-On Delay Time	$\text{t}_{\text{d(on)}}$		—	13	26	
Turn-On Rise Time	t_r	$\text{V}_{\text{DD}} = 15\text{V}, \text{R}_L = 15\Omega$	—	16	29	ns
Turn-Off Delay Time	$\text{t}_{\text{d(off)}}$	$\text{I}_D \approx 1\text{A}, \text{V}_{\text{GEN}} = 10\text{V}$	—	94	132	
Turn-Off Fall Time	t_f	$\text{R}_G = 6\Omega$	—	38	57	
Input Capacitance	C_{iss}	$\text{V}_{\text{DS}} = 15\text{V}, \text{V}_{\text{GS}} = 0\text{V}$	—	3240	—	pF
Output Capacitance	C_{oss}		—	625	—	
Reverse Transfer Capacitance	C_{rss}	$f = 1.0\text{MHz}$	—	285	—	
Source-Drain Diode						
Max. Diode Forward Current	I_s	—	—	—	75	A
Diode Forward Voltage	V_{SD}	$\text{I}_s = 38\text{A}, \text{V}_{\text{GS}} = 0\text{V}$	—	0.9	1.3	V

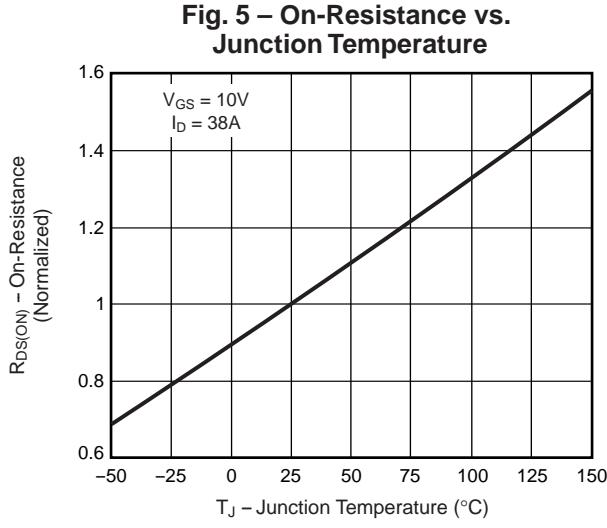
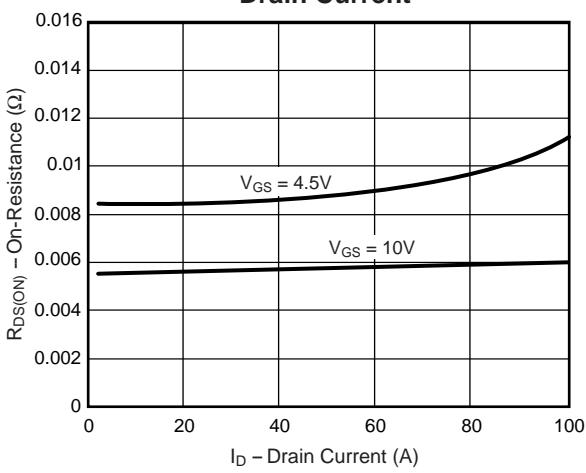
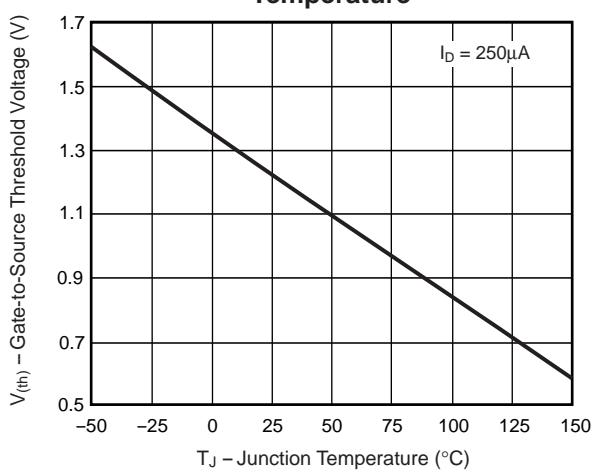
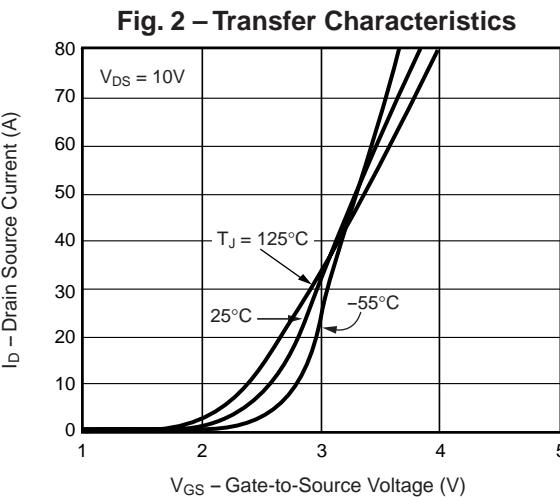
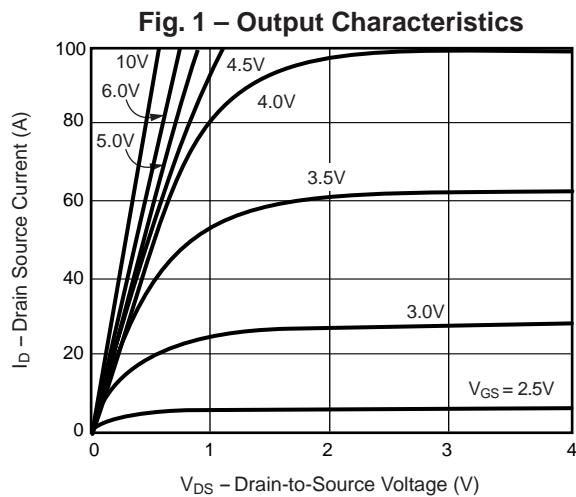
Note:

(1) Pulse test; pulse width $\leq 300\ \mu\text{s}$, duty cycle $\leq 2\%$



N-Channel Enhancement-Mode MOSFET

Ratings and Characteristic Curves (TA = 25°C unless otherwise noted)



N-Channel Enhancement-Mode MOSFET

Ratings and Characteristic Curves ($T_A = 25^\circ\text{C}$ unless otherwise noted)

Fig. 6 – On-Resistance vs. Gate-to-Source Voltage

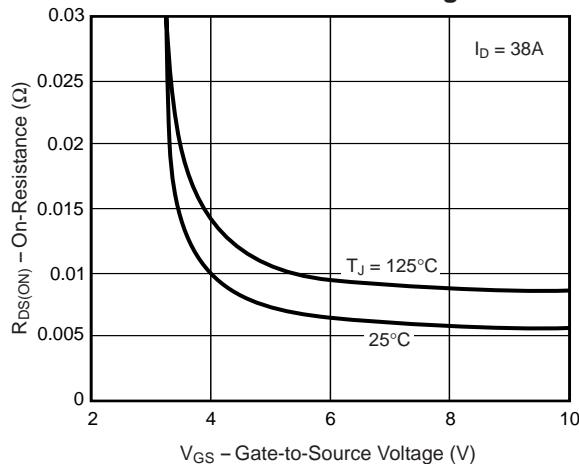


Fig. 7 – Gate Charge

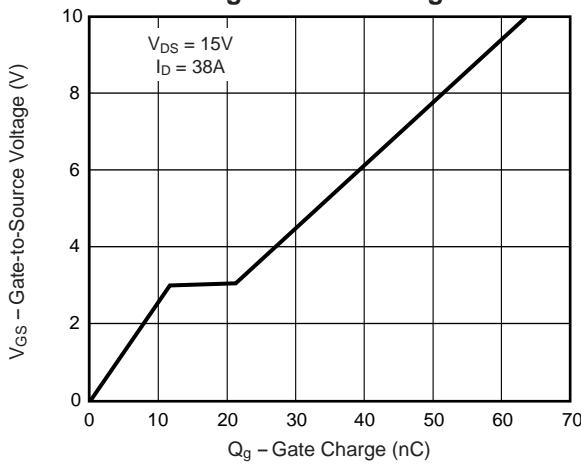


Fig. 8 – Capacitance

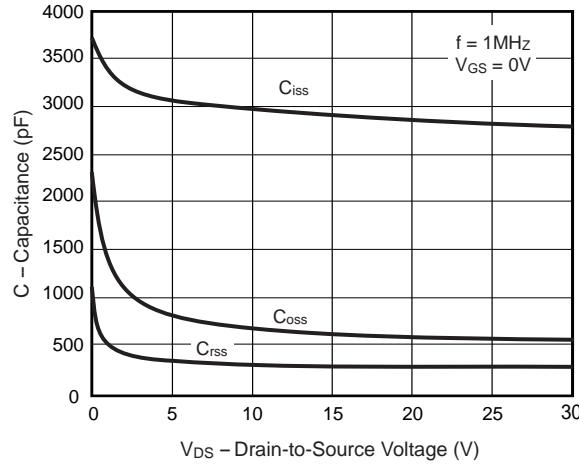
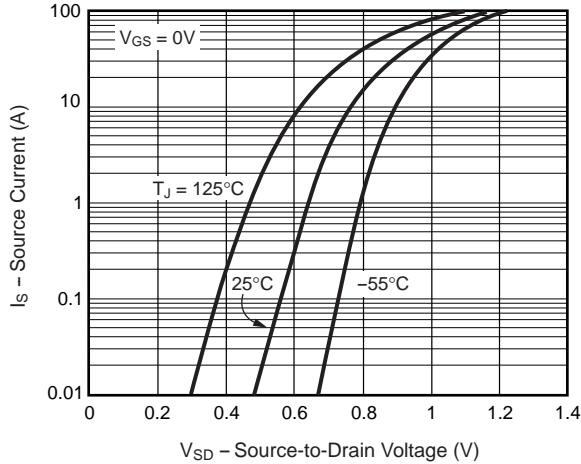


Fig. 9 – Source-Drain Diode Forward Voltage



N-Channel Enhancement-Mode MOSFET

Ratings and Characteristic Curves ($T_A = 25^\circ\text{C}$ unless otherwise noted)

Fig. 10 – Breakdown Voltage vs. Junction Temperature

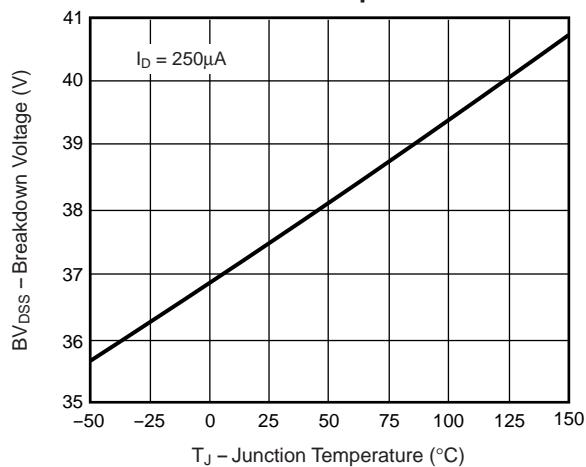


Fig. 12 – Power vs. Pulse Duration

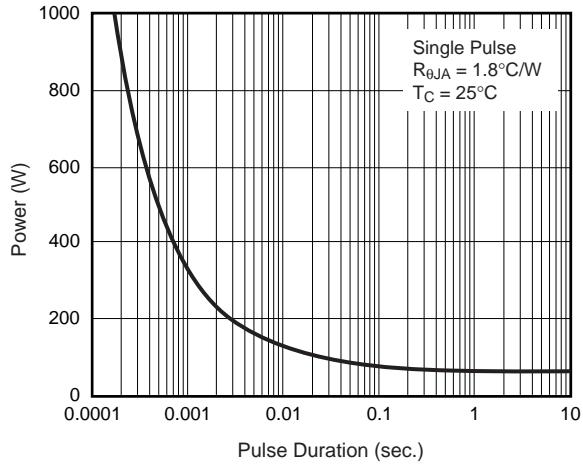


Fig. 11 – Transient Thermal Impedance

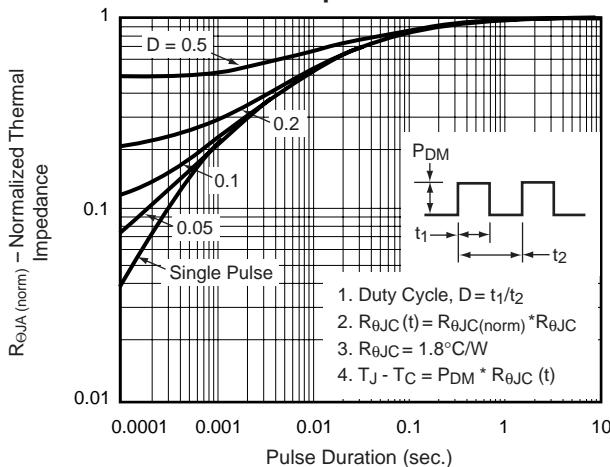


Fig. 13 – Maximum Safe Operating Area

